Se	arch No	otes

Application/Control No.	Applicant(s)/Patent under Reexamination	7
10/039,125	PRAKASH ET AL.	
Examiner	Art Unit	
Hai V. Nguyen	2142	

SEARCHED			
Class	Subclass	Date	Examiner
370	389	6/21/2006	HN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search Updated (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB) (see search history printout report)	6/21/2006	HN
Limited Classified search: 370/389 (see search history printout report)	6/21/2006	HN

